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Yu, Y. B.;
Nuclear Science, IEEE Transactions on
Volume 29, Issue 6, Dec. 1982 Page(s):1930 - 1934
Digital Object Identifier 10.1109/TNS.1982.4336473

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Chan, M.H.; Yu, Y.B.; Constantinides, A.G.;
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☐ 3. **Low bit rate video coding using variable block size model**
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Acoustics, Speech, and Signal Processing, 1990. ICASSP-90., 1990 International Conference on
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